





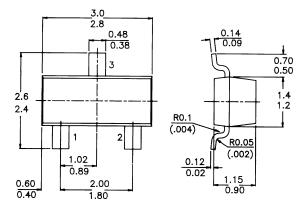
## **SOT-23 Formed SMD Package**

### **CMBT3905**

# SILICON EPITAXIAL TRANSISTOR

P-N-P transistor

MarkingCMBT3905 = 2Y PACKAGE OUTLINE DETAILS ALL DIMENSIONS IN mm



#### Pin configuration

1 = BASE

2 = EMITTER

3 = COLLECTOR



#### ABSOLUTE MAXIMUM RATINGS

Collector–base voltage (open emitter)	$-V_{CBO}$	max.	40	V
Collector–emitter voltage (open base)	$-V_{CEO}$	max.	40	V
Emitter–base voltage (open collector)	$-V_{EBO}$	max.	5	V
Collector current (d.c.)	$-I_C$	max.	200	mA
Total power dissipation up to $T_{amb} = 60$ °C	$P_{tot}$	max.	250	mW
D.C. current gain				
$-I_C = 10 \ mA; -V_{CE} = 1 \ V$	$h_{FE}$	50 to	150	
Transition frequency at $f = 100 \text{ MHz}$				
$-I_C = 10 \ mA; \ -V_{CE} = 20 \ V$	$f_T$	min.	200	MHz

## **CMBT3905**

<b>RATINGS</b> (at $T_A = 25^{\circ}\text{C}$ unless otherwise specified) Limiting values				
Collector-base voltage (open emitter)	$-V_{CB0}$	max.	40	V
Collector-emitter voltage (open base)	$-V_{CE0}$	max.	40	
Emitter-base voltage (open collector)	$-V_{EB0}$	max.	5	V
Collector current (d.c.)	$-I_C$	max.	200	mA
Total power dissipation*				
$up to T_{amb} = 25  ^{\circ}C$	$P_{tot}$	max.	250	
Storage temperature	$T_{stg}$	−55 to	+150	) °C
THERMAL CHARACTERISTICS				
$T_j = P(R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$				
Thermal resistance				
from junction to ambient	$R_{th}$ $j-a$	=	200	℃W
<b>CHARACTERISTICS</b> (at $T_A = 25^{\circ}$ C unless otherwise specifical $T_{amb} = 25^{\circ}$ C unless otherwise specified	ied)			
Collector–emitter breakdown voltage				
$-I_C = 1 mA; l_B = 0$	-V(BR)CE0	min.	40	V
Collector-base breakdown voltage	* *		4.0	
$-I_C = 10\mu A; I_E = 0$	$-V_{(BR)CB0}$	mın.	40	V
Emitter-base breakdown voltage $-I_E = 10 \ \mu A; I_C = 0$	$-V_{(BR)EB0}$	min	5	V
Collector cut-off current	-v (BK)EB0	mu.	3	V
$-V_{CE} = 30 \ V; -V_{EB} = 3 \ V$	$-I_{CEX}$	max.	50	nA
Base current	CLA			
with reverse biased emitter junction	$-I_{BEX}$	max.	50	nA
Output capacitance at $f = 100 \text{ kHz}$				
$I_E = 0; -V_{CB} = 5 V$	$C_c$	max.	4.5	pF
Input capacitance at $f = 100 \text{ kHz}$				_
$I_C = 0; -V_{BE} = 0.5 V$	$C_e$	max.	10	pF
Saturation voltages				
$-I_C = 10 mA; -I_B = 1 mA$	-V <sub>CEsat</sub>	max.	0,25	V
$-I_C = 50 mA; -I_B = 5 mA$	$-V_{CEsat}$	max.	0,4	V
$-I_C = 10 \ mA; -I_B = 1 \ mA$	-V <sub>BEsat</sub>	min.	0,65	V
	22000		0,85	
			,	
$-I_C = 50 mA; -I_B = 5 mA$	$-V_{BEsat}$	max.	0,95	V
D.C. current gain				
$-I_C = 0.1 \text{ mA}; -V_{CE} = 1 \text{ V}$	$h_{FE}$	min.	30	
$-I_C = 1 mA; -V_{CE} = 1 V$	$h_{FE}$	min.	40	
$-I_C = 10 \ mA; -V_{CE} = 1 \ V$	$h_{FE}$		F0	
10 - 10 m21, VCE - 1 V	"FE	min. max.	50 150	
		mua.	100	

$-I_C = 50 \text{ mA; } -V_{CE} = 1 \text{ V}$	$h_{FE}$	min.	30
$-I_C = 100 \ mA; -V_{CE} = 1 \ V$	$h_{FE}$	min.	15
Transition frequency at $f = 100 \text{ MHz}$			
$-I_C = 10mA; -V_{CE} = 20V$	$f_T$	min.	200 MHz
Noise figure at $R_S = 1 k\Omega$			
$-I_C = 100\mu A; -V_{CE} = 5 V$			
f = 10  Hz  to  15.7  kHz	F	max.	4 dB
Small Signal Current Gain			
$-V_{CE} = 10V$ ; $-I_{C} = 1 \text{ mA}$ ; $f = 1 \text{ KHz}$	$h_{fe}$	min.	50
	,	max.	200

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